

## **The comparison of photoluminescence decay in YAG:Er, ZnO and SiO<sub>2</sub> crystals**

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We report on the intensity and time resolved photoluminescence (PL) measurements in the visible spectral range at wavelengths 350-800 nm using the phase delay method under sine wave UV excitation. Yttrium aluminium garnet (Y<sub>3</sub>Al<sub>5</sub>O<sub>12</sub>, YAG), zinc oxide (ZnO) and silicon oxide (SiO<sub>2</sub>) are crystalline materials, known for their excellent optical properties and mechanical, chemical and temperature stability. The YAG:Er crystals were grown by the micro-pulling-down method at the Institute of Physics in Prague [1], ZnO crystals by hydrothermal growth at the Institute of Chemistry in Bratislava [2] and the SiO<sub>2</sub> micro powder was purchased from Sigma-Aldrich and exposed to inductively coupled plasma (ICP) at the Institute of Physics to create surface-related defects. Their PL spectra were measured at a room temperature using the UV LED sine wave modulated by 50 MHz Keithley 3390 generator, dispersive monochromator, 10 MHz red-enhanced photomultiplier, 1 MHz current amplifier 10<sup>5</sup> V/A, 200 MHz oscilloscope, and a 100 kHz lock-in amplifier. The sensitivity of the oscilloscope is about 3 orders of magnitude lower than the sensitivity of the lock-in amplifier. Our setup allows to measure the mean PL decay with a time resolution of about 10 ns at 100 kHz. While YAG:Er shows well resolved PL peaks with mean decay time of several μs related to the Stark splitting of Er<sup>3+</sup> (4f<sup>11</sup>) states, the defect-related PL spectra of ZnO and SiO<sub>2</sub> show broad defect-related bands with significantly faster mean decay times (in the order of tens or hundreds ns in ZnO, depending on doping, and below 10 ns in SiO<sub>2</sub>).

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- [1] M. Buryi, et al., The role of Er<sup>3+</sup> content in the luminescence properties of Y<sub>3</sub>Al<sub>5</sub>O<sub>12</sub> single crystal: Incorporation into the lattice and defect states creation, *Crystals* 13 (2023) 562(1-14).
- [2] M. Buryi, et al., Peculiarities of erbium incorporation into ZnO microrods at high doping level leading to up conversion and the morphology change. Influence on excitonic as well as shallow donor states, *Appl. Surf. Sci.* 611 (2023) 155651(1-14).